

Notice of References Cited	Application/Control No. 10/806,172		Applicant(s)/Patent Under Reexamination OYABU ET AL.	
	Examiner DAVID P. RASHID		Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,461,704	10-1995	Wakabayashi et al.	358/1.15
*	B	US-5,473,741	12-1995	Neufelder et al.	345/619
*	C	US-6,498,868	12-2002	Klassen, R. Victor	382/298
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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